Search Notes

Application/Control No.
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Applicant(s)/Patent under Reexamination

10/664,662 Examiner ISHIKAWA ET AL.
Art Unit

Examiner

Huy D. Nguyen

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SEARCHED				
Class	Subclass	Date	Examiner	
455	423	2/8/2006	HN	
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Updated	search	10/6/2006	HN	
Updated	· search	3/17/2007	HN	
Updated	search	8/19/2007	HN	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
455	423	8/19/2007	HN	
	436			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East (USPAT, US-PGPUB, JPO, EPO, DERWENT). See search history printout.	2/8/2006	HN		
East; Text search (USPAT, US- PGPUB, JPO, EPO, DERWENT). See search history printout.	10/6/2006	HN		
East; Text search (USPAT, US- PGPUB, JPO, EPO, DERWENT). See search history printout.	3/17/2007	HN		
East; Text search (USPAT, US- PGPUB, JPO, EPO, DERWENT). See search history printout.	8/19/2007	HN		
See interference search printout.	8/19/2007	HN		